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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

Product Status	Active
Number of LABs/CLBs	4075
Number of Logic Elements/Cells	52160
Total RAM Bits	2764800
Number of I/O	150
Number of Gates	-
Voltage - Supply	0.95V ~ 1.05V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	324-LFBGA, CSPBGA
Supplier Device Package	324-CSPBGA (15x15)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7a50t-2cs325i">https://www.e-xfl.com/product-detail/xilinx/xc7a50t-2cs325i</a>

**Table 3: DC Characteristics Over Recommended Operating Conditions (Cont'd)**

Symbol	Description	Min	Typ <sup>(1)</sup>	Max	Units
n	Temperature diode ideality factor	—	1.010	—	—
r	Temperature diode series resistance	—	2	—	Ω

**Notes:**

1. Typical values are specified at nominal voltage, 25°C.
2. This measurement represents the die capacitance at the pad, not including the package.
3. Maximum value specified for worst case process at 25°C.
4. Termination resistance to a V<sub>CCO</sub>/2 level.

**Table 4: V<sub>IN</sub> Maximum Allowed AC Voltage Overshoot and Undershoot for 3.3V HR I/O Banks<sup>(1)</sup>**

AC Voltage Overshoot	% of UI @-40°C to 100°C	AC Voltage Undershoot	% of UI @-40°C to 100°C
V <sub>CCO</sub> + 0.40	100	-0.40	100
V <sub>CCO</sub> + 0.45	100	-0.45	61.7
V <sub>CCO</sub> + 0.50	100	-0.50	25.8
V <sub>CCO</sub> + 0.55	100	-0.55	11.0
V <sub>CCO</sub> + 0.60	46.6	-0.60	4.77
V <sub>CCO</sub> + 0.65	21.2	-0.65	2.10
V <sub>CCO</sub> + 0.70	9.75	-0.70	0.94
V <sub>CCO</sub> + 0.75	4.55	-0.75	0.43
V <sub>CCO</sub> + 0.80	2.15	-0.80	0.20
V <sub>CCO</sub> + 0.85	1.02	-0.85	0.09
V <sub>CCO</sub> + 0.90	0.49	-0.90	0.04
V <sub>CCO</sub> + 0.95	0.24	-0.95	0.02

**Notes:**

1. A total of 200 mA per bank should not be exceeded.

**Table 5: Typical Quiescent Supply Current**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
I <sub>CCINTQ</sub>	Quiescent V <sub>CCINT</sub> supply current	XC7A100T	155	155	155	108	mA	
		XC7A200T	328	328	328	232	mA	
I <sub>CCOQ</sub>	Quiescent V <sub>CCO</sub> supply current	XC7A100T	4	4	4	4	mA	
		XC7A200T	5	5	5	5	mA	
I <sub>CCAUXQ</sub>	Quiescent V <sub>CCAUX</sub> supply current	XC7A100T	36	36	36	36	mA	
		XC7A200T	73	73	73	73	mA	
I <sub>CCBRAMQ</sub>	Quiescent V <sub>CCBRAM</sub> supply current	XC7A100T	4	4	4	4	mA	
		XC7A200T	11	11	11	11	mA	

**Notes:**

1. Typical values are specified at nominal voltage, 85°C junction temperature (T<sub>j</sub>) with single-ended SelectIO resources.
2. Typical values are for blank configured devices with no output current loads, no active input pull-up resistors, all I/O pins are 3-state and floating.
3. Use the Xilinx Power Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate static power consumption for conditions other than those specified.

## DC Input and Output Levels

Values for  $V_{IL}$  and  $V_{IH}$  are recommended input voltages. Values for  $I_{OL}$  and  $I_{OH}$  are guaranteed over the recommended operating conditions at the  $V_{OL}$  and  $V_{OH}$  test points. Only selected standards are tested. These are chosen to ensure that all standards meet their specifications. The selected standards are tested at a minimum  $V_{CCO}$  with the respective  $V_{OL}$  and  $V_{OH}$  voltage levels shown. Other standards are sample tested.

Table 8: SelectIO DC Input and Output Levels<sup>(1)(2)</sup>

I/O Standard	$V_{IL}$		$V_{IH}$		$V_{OL}$	$V_{OH}$	$I_{OL}$	$I_{OH}$
	$V$ , Min	$V$ , Max	$V$ , Min	$V$ , Max	$V$ , Max	$V$ , Min	mA, Max	mA, Min
HSTL_I	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8.00	-8.00
HSTL_I_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8.00	-8.00
HSTL_II	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16.00	-16.00
HSTL_II_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16.00	-16.00
HSUL_12	-0.300	$V_{REF} - 0.130$	$V_{REF} + 0.130$	$V_{CCO} + 0.300$	20% $V_{CCO}$	80% $V_{CCO}$	0.10	-0.10
LVCMOS12	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 3	Note 3
LVCMOS15	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	25% $V_{CCO}$	75% $V_{CCO}$	Note 4	Note 4
LVCMOS18	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.450	$V_{CCO} - 0.450$	Note 5	Note 5
LVCMOS25	-0.300	0.7	1.700	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 4	Note 4
LVCMOS33	-0.300	0.8	2.000	3.450	0.400	$V_{CCO} - 0.400$	Note 4	Note 4
LVTTL	-0.300	0.8	2.000	3.450	0.400	2.400	Note 5	Note 5
MOBILE_DDR	-0.300	20% $V_{CCO}$	80% $V_{CCO}$	$V_{CCO} + 0.300$	10% $V_{CCO}$	90% $V_{CCO}$	0.10	-0.10
PCI33_3	-0.500	30% $V_{CCO}$	50% $V_{CCO}$	$V_{CCO} + 0.500$	10% $V_{CCO}$	90% $V_{CCO}$	1.50	-0.50
SSTL135	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	13.00	-13.00
SSTL135_R	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	8.90	-8.90
SSTL15	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	13.00	-13.00
SSTL15_R	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	8.90	-8.90
SSTL18_I	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.470$	$V_{CCO}/2 + 0.470$	8.00	-8.00
SSTL18_II	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.600$	$V_{CCO}/2 + 0.600$	13.40	-13.40

**Notes:**

- Tested according to relevant specifications.
- 3.3V and 2.5V standards are only supported in 3.3V I/O banks.
- Supported drive strengths of 4, 8, or 12 mA in HR I/O banks.
- Supported drive strengths of 4, 8, 12, or 16 mA in HR I/O banks.
- Supported drive strengths of 4, 8, 12, 16, or 24 mA in HR I/O banks.
- For detailed interface specific DC voltage levels, see [UG471: 7 Series FPGAs SelectIO Resources User Guide](#).

## IOB Pad Input/Output/3-State

Table 16 summarizes the values of standard-specific data input delay adjustments, output delays terminating at pads (based on standard) and 3-state delays.

- $T_{IOP}$  is described as the delay from IOB pad through the input buffer to the I-pin of an IOB pad. The delay varies depending on the capability of the SelectIO input buffer.
- $T_{IOOP}$  is described as the delay from the O pin to the IOB pad through the output buffer of an IOB pad. The delay varies depending on the capability of the SelectIO output buffer.
- $T_{IOTP}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is disabled. The delay varies depending on the SelectIO capability of the output buffer. In HR I/O banks, the IN\_TERM termination turn-on time is always faster than  $T_{IOTP}$  when the INTERMDISABLE pin is used.

Table 16: 3.3V IOB High Range (HR) Switching Characteristics

I/O Standard	$T_{IOP}$				$T_{IOOP}$				$T_{IOTP}$				Units	
	Speed Grade				Speed Grade				Speed Grade					
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V			
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
LVTTL_S4	1.26	1.34	1.41	1.58	3.80	3.93	4.18	4.41	4.37	4.59	5.01	5.06	ns	
LVTTL_S8	1.26	1.34	1.41	1.58	3.54	3.66	3.92	4.15	4.11	4.32	4.75	4.80	ns	
LVTTL_S12	1.26	1.34	1.41	1.58	3.52	3.65	3.90	4.13	4.09	4.31	4.73	4.78	ns	
LVTTL_S16	1.26	1.34	1.41	1.58	3.07	3.19	3.45	3.68	3.64	3.85	4.28	4.33	ns	
LVTTL_S24	1.26	1.34	1.41	1.58	3.29	3.41	3.67	3.90	3.86	4.07	4.50	4.55	ns	
LVTTL_F4	1.26	1.34	1.41	1.58	3.26	3.38	3.64	3.86	3.83	4.04	4.46	4.51	ns	
LVTTL_F8	1.26	1.34	1.41	1.58	2.74	2.87	3.12	3.35	3.31	3.52	3.95	4.00	ns	
LVTTL_F12	1.26	1.34	1.41	1.58	2.73	2.85	3.10	3.33	3.29	3.51	3.93	3.98	ns	
LVTTL_F16	1.26	1.34	1.41	1.58	2.55	2.68	2.93	3.16	3.12	3.34	3.76	3.81	ns	
LVTTL_F24	1.26	1.34	1.41	1.58	2.52	2.65	2.90	3.22	3.09	3.31	3.73	3.87	ns	
LVDS_25	0.73	0.81	0.88	0.90	1.29	1.41	1.67	1.86	1.86	2.07	2.49	2.51	ns	
MINI_LVDS_25	0.73	0.81	0.88	0.90	1.27	1.40	1.65	1.88	1.84	2.06	2.48	2.53	ns	
BLVDS_25	0.73	0.81	0.88	0.90	1.84	1.96	2.21	2.44	2.40	2.62	3.04	3.09	ns	
RSDS_25 (point to point)	0.73	0.81	0.88	0.90	1.27	1.40	1.65	1.88	1.84	2.06	2.48	2.53	ns	
PPDS_25	0.73	0.81	0.88	0.90	1.29	1.41	1.67	1.88	1.86	2.07	2.49	2.53	ns	
TMDS_33	0.73	0.81	0.88	0.90	1.41	1.54	1.79	1.99	1.98	2.20	2.62	2.64	ns	
PCI33_3	1.24	1.32	1.39	1.57	3.10	3.22	3.48	3.71	3.67	3.88	4.31	4.36	ns	
HSUL_12	0.67	0.75	0.82	0.87	1.80	1.93	2.18	2.41	2.37	2.59	3.01	3.06	ns	
DIFF_HSUL_12	0.68	0.76	0.83	0.88	1.80	1.93	2.18	2.21	2.37	2.59	3.01	2.86	ns	
HSTL_I_S	0.67	0.75	0.82	0.87	1.62	1.74	1.99	2.19	2.19	2.40	2.82	2.84	ns	
HSTL_II_S	0.65	0.73	0.80	0.85	1.41	1.54	1.79	1.99	1.98	2.20	2.62	2.64	ns	
HSTL_I_18_S	0.67	0.75	0.82	0.87	1.29	1.41	1.67	1.86	1.86	2.07	2.49	2.51	ns	
HSTL_II_18_S	0.66	0.75	0.81	0.87	1.41	1.54	1.79	1.97	1.98	2.20	2.62	2.62	ns	
DIFF_HSTL_I_S	0.68	0.76	0.83	0.85	1.59	1.71	1.96	2.13	2.15	2.37	2.79	2.78	ns	
DIFF_HSTL_II_S	0.68	0.76	0.83	0.85	1.51	1.63	1.88	2.07	2.08	2.29	2.71	2.72	ns	
DIFF_HSTL_I_18_S	0.71	0.79	0.86	0.87	1.38	1.51	1.76	1.96	1.95	2.17	2.59	2.61	ns	
DIFF_HSTL_II_18_S	0.70	0.78	0.85	0.87	1.46	1.58	1.84	2.00	2.03	2.24	2.67	2.65	ns	
HSTL_I_F	0.67	0.75	0.82	0.87	1.10	1.22	1.48	1.69	1.67	1.88	2.31	2.34	ns	

Table 16: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V			
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
LVCMOS15_F4	0.77	0.86	0.93	0.98	1.85	1.97	2.23	2.27	2.42	2.63	3.06	2.92	ns	
LVCMOS15_F8	0.77	0.86	0.93	0.98	1.60	1.72	1.98	2.21	2.17	2.38	2.81	2.86	ns	
LVCMOS15_F12	0.77	0.86	0.93	0.98	1.35	1.47	1.73	1.96	1.92	2.13	2.56	2.61	ns	
LVCMOS15_F16	0.77	0.86	0.93	0.98	1.34	1.46	1.71	1.94	1.90	2.12	2.54	2.59	ns	
LVCMOS12_S4	0.87	0.95	1.02	1.08	2.57	2.69	2.95	3.18	3.14	3.35	3.78	3.83	ns	
LVCMOS12_S8	0.87	0.95	1.02	1.08	2.09	2.21	2.46	2.69	2.65	2.87	3.29	3.34	ns	
LVCMOS12_S12	0.87	0.95	1.02	1.08	1.79	1.91	2.17	2.40	2.36	2.57	2.99	3.05	ns	
LVCMOS12_F4	0.87	0.95	1.02	1.08	1.98	2.10	2.35	2.58	2.54	2.76	3.18	3.23	ns	
LVCMOS12_F8	0.87	0.95	1.02	1.08	1.54	1.66	1.92	2.15	2.11	2.32	2.75	2.80	ns	
LVCMOS12_F12	0.87	0.95	1.02	1.08	1.38	1.51	1.76	1.97	1.95	2.16	2.59	2.62	ns	
SSTL135_S	0.67	0.75	0.82	0.87	1.35	1.47	1.73	1.93	1.92	2.13	2.56	2.58	ns	
SSTL15_S	0.60	0.68	0.75	0.80	1.30	1.43	1.68	1.88	1.87	2.09	2.51	2.53	ns	
SSTL18_I_S	0.67	0.75	0.82	0.87	1.67	1.79	2.04	2.24	2.23	2.45	2.87	2.89	ns	
SSTL18_II_S	0.67	0.75	0.82	0.87	1.31	1.43	1.68	1.91	1.87	2.09	2.51	2.56	ns	
DIFF_SSTL135_S	0.68	0.76	0.83	0.87	1.35	1.47	1.73	1.93	1.92	2.13	2.56	2.58	ns	
DIFF_SSTL15_S	0.68	0.76	0.83	0.87	1.30	1.43	1.68	1.88	1.87	2.09	2.51	2.53	ns	
DIFF_SSTL18_I_S	0.71	0.79	0.86	0.87	1.68	1.80	2.06	2.24	2.25	2.46	2.89	2.89	ns	
DIFF_SSTL18_II_S	0.71	0.79	0.86	0.87	1.38	1.51	1.76	1.94	1.95	2.17	2.59	2.59	ns	
SSTL135_F	0.67	0.75	0.82	0.87	1.12	1.24	1.49	1.71	1.69	1.90	2.32	2.36	ns	
SSTL15_F	0.60	0.68	0.75	0.80	1.07	1.19	1.45	1.68	1.64	1.85	2.28	2.33	ns	
SSTL18_I_F	0.67	0.75	0.82	0.87	1.12	1.24	1.49	1.72	1.69	1.90	2.32	2.37	ns	
SSTL18_II_F	0.67	0.75	0.82	0.87	1.12	1.24	1.49	1.71	1.69	1.90	2.32	2.36	ns	
DIFF_SSTL135_F	0.68	0.76	0.83	0.87	1.12	1.24	1.49	1.71	1.69	1.90	2.32	2.36	ns	
DIFF_SSTL15_F	0.68	0.76	0.83	0.87	1.07	1.19	1.45	1.68	1.64	1.85	2.28	2.33	ns	
DIFF_SSTL18_I_F	0.71	0.79	0.86	0.87	1.23	1.35	1.60	1.80	1.79	2.01	2.43	2.45	ns	
DIFF_SSTL18_II_F	0.71	0.79	0.86	0.87	1.21	1.33	1.59	1.79	1.78	1.99	2.42	2.44	ns	

Table 17 specifies the values of T<sub>IOTPHZ</sub> and T<sub>IOIBUFDISABLE</sub>. T<sub>IOTPHZ</sub> is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is enabled (i.e., a high impedance state). T<sub>IOIBUFDISABLE</sub> is described as the IOB delay from IBUFDISABLE to O output. In HR I/O banks, the internal IN\_TERM termination turn-off time is always faster than T<sub>IOTPHZ</sub> when the INTERMDISABLE pin is used.

Table 17: IOB 3-state Output Switching Characteristics

Symbol	Description	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
T <sub>IOTPHZ</sub>	T input to pad high-impedance	2.06	2.19	2.37	2.19	ns	
T <sub>IOIBUFDISABLE</sub>	IBUF turn-on time from IBUFDISABLE to O output	2.11	2.30	2.60	2.30	ns	

## Input/Output Logic Switching Characteristics

Table 18: ILOGIC Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold</b>						
T <sub>ICE1CK/T<sub>ICKCE1</sub></sub>	CE1 pin setup/hold with respect to CLK	0.48/0.02	0.54/0.02	0.76/0.02	0.40/-0.07	ns
T <sub>ISRCK/T<sub>ICKSR</sub></sub>	SR pin setup/hold with respect to CLK	0.60/0.01	0.70/0.01	1.13/0.01	0.88/-0.35	ns
T <sub>IDOCK/T<sub>IOCKD</sub></sub>	D pin setup/hold with respect to CLK without Delay	0.01/0.27	0.01/0.29	0.01/0.33	0.01/0.33	ns
T <sub>IDOCKD/T<sub>IOCKDD</sub></sub>	DDLY pin setup/hold with respect to CLK (using IDELAY)	0.02/0.27	0.02/0.29	0.02/0.33	0.01/0.33	ns
<b>Combinatorial</b>						
T <sub>IDI</sub>	D pin to O pin propagation delay, no Delay	0.11	0.11	0.13	0.14	ns
T <sub>IDID</sub>	DDLY pin to O pin propagation delay (using IDELAY)	0.11	0.12	0.14	0.15	ns
<b>Sequential Delays</b>						
T <sub>IDLO</sub>	D pin to Q1 pin using flip-flop as a latch without Delay	0.41	0.44	0.51	0.54	ns
T <sub>IDLOD</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY)	0.41	0.44	0.51	0.55	ns
T <sub>ICKQ</sub>	CLK to Q outputs	0.53	0.57	0.66	0.71	ns
T <sub>RQ_ILOGIC</sub>	SR pin to OQ/TQ out	0.96	1.08	1.32	1.32	ns
T <sub>GSRQ_ILOGIC</sub>	Global set/reset to Q outputs	7.60	7.60	10.51	11.39	ns
<b>Set/Reset</b>						
T <sub>RPW_ILOGIC</sub>	Minimum pulse width, SR inputs	0.61	0.72	0.72	0.68	ns, Min

Table 19: OLOGIC Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold</b>						
T <sub>ODCK/T<sub>OCKD</sub></sub>	D1/D2 pins setup/hold with respect to CLK	0.67/-0.11	0.71/-0.11	0.84/-0.11	0.60/-0.18	ns
T <sub>OOCCK/T<sub>OCKOCE</sub></sub>	OCE pin setup/hold with respect to CLK	0.32/0.58	0.34/0.58	0.51/0.58	0.21/-0.10	ns
T <sub>OSRCK/T<sub>OCKSR</sub></sub>	SR pin setup/hold with respect to CLK	0.37/0.21	0.44/0.21	0.80/0.21	0.62/-0.25	ns
T <sub>OTCK/T<sub>OCKT</sub></sub>	T1/T2 pins setup/hold with respect to CLK	0.69/-0.14	0.73/-0.14	0.89/-0.14	0.60/-0.18	ns
T <sub>TOTCECK/T<sub>OCKTCE</sub></sub>	TCE pin setup/hold with respect to CLK	0.32/0.01	0.34/0.01	0.51/0.01	0.22/-0.10	ns
<b>Combinatorial</b>						
T <sub>ODQ</sub>	D1 to OQ out or T1 to TQ out	0.83	0.96	1.16	1.36	ns
<b>Sequential Delays</b>						
T <sub>OCKQ</sub>	CLK to OQ/TQ out	0.47	0.49	0.56	0.63	ns
T <sub>RQ_OLOGIC</sub>	SR pin to OQ/TQ out	0.72	0.80	0.95	1.12	ns
T <sub>GSRQ_OLOGIC</sub>	Global set/reset to Q outputs	7.60	7.60	10.51	11.39	ns
<b>Set/Reset</b>						
T <sub>RPW_OLOGIC</sub>	Minimum pulse width, SR inputs	0.64	0.74	0.74	0.68	ns, Min

## Input Serializer/Deserializer Switching Characteristics

Table 20: ISERDES Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold for Control Lines</b>						
T <sub>ISCCCK_BITSILIP</sub> /T <sub>ISCKC_BITSILIP</sub>	BITSLIP pin setup/hold with respect to CLKDIV	0.01/0.14	0.02/0.15	0.02/0.17	0.02/0.21	ns
T <sub>ISCCCK_CE</sub> / T <sub>ISCKC_CE</sub> <sup>(2)</sup>	CE pin setup/hold with respect to CLK (for CE1)	0.45/-0.01	0.50/-0.01	0.72/-0.01	0.35/-0.11	ns
T <sub>ISCCCK_CE2</sub> / T <sub>ISCKC_CE2</sub> <sup>(2)</sup>	CE pin setup/hold with respect to CLKDIV (for CE2)	-0.10/0.33	-0.10/0.36	-0.10/0.40	-0.17/0.40	ns
<b>Setup/Hold for Data Lines</b>						
T <sub>ISDCK_D</sub> /T <sub>ISCKD_D</sub>	D pin setup/hold with respect to CLK	-0.02/0.12	-0.02/0.14	-0.02/0.17	-0.04/0.19	ns
T <sub>ISDCK_DDLY</sub> /T <sub>ISCKD_DDLY</sub>	DDLY pin setup/hold with respect to CLK (using IDELAY) <sup>(1)</sup>	-0.02/0.12	-0.02/0.14	-0.02/0.17	-0.03/0.19	ns
T <sub>ISDCK_D_DDR</sub> /T <sub>ISCKD_D_DDR</sub>	D pin setup/hold with respect to CLK at DDR mode	-0.02/0.12	-0.02/0.14	-0.02/0.17	-0.04/0.19	ns
T <sub>ISDCK_DDLY_DDR</sub> /T <sub>ISCKD_DDLY_DDR</sub>	D pin setup/hold with respect to CLK at DDR mode (using IDELAY) <sup>(1)</sup>	0.12/0.12	0.14/0.14	0.17/0.17	0.19/0.19	ns
<b>Sequential Delays</b>						
T <sub>ISCKO_Q</sub>	CLKDIV to out at Q pin	0.53	0.54	0.66	0.67	ns
<b>Propagation Delays</b>						
T <sub>ISDO_DO</sub>	D input to DO output pin	0.11	0.11	0.13	0.14	ns

**Notes:**

1. Recorded at 0 tap value.
2. T<sub>ISCCCK\_CE2</sub> and T<sub>ISCKC\_CE2</sub> are reported as T<sub>ISCCCK\_CE</sub>/T<sub>ISCKC\_CE</sub> in TRACE report.

## Output Serializer/Deserializer Switching Characteristics

Table 21: OSERDES Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold</b>						
T <sub>OSDCK_D</sub> /T <sub>OSCKD_D</sub>	D input setup/hold with respect to CLKDIV	0.42/0.03	0.45/0.03	0.63/0.03	0.44/-0.25	ns
T <sub>OSDCK_T</sub> /T <sub>OSCKD_T</sub> <sup>(1)</sup>	T input setup/hold with respect to CLK	0.69/-0.13	0.73/-0.13	0.88/-0.13	0.60/-0.25	ns
T <sub>OSDCK_T2</sub> /T <sub>OSCKD_T2</sub> <sup>(1)</sup>	T input setup/hold with respect to CLKDIV	0.31/-0.13	0.34/-0.13	0.39/-0.13	0.46/-0.25	ns
T <sub>oscck_oce</sub> /T <sub>osckc_oce</sub>	OCE input setup/hold with respect to CLK	0.32/0.58	0.34/0.58	0.51/0.58	0.21/-0.15	ns
T <sub>oscck_s</sub>	SR (reset) input setup with respect to CLKDIV	0.47	0.52	0.85	0.70	ns
T <sub>oscck_tce</sub> /T <sub>osckc_tce</sub>	TCE input setup/hold with respect to CLK	0.32/0.01	0.34/0.01	0.51/0.01	0.22/-0.15	ns
<b>Sequential Delays</b>						
T <sub>oscko_oq</sub>	Clock to out from CLK to OQ	0.40	0.42	0.48	0.54	ns
T <sub>oscko_tq</sub>	Clock to out from CLK to TQ	0.47	0.49	0.56	0.63	ns
<b>Combinatorial</b>						
T <sub>osdo_ttq</sub>	T input to TQ Out	0.83	0.92	1.11	1.18	ns

**Notes:**

- T<sub>OSDCK\_T2</sub> and T<sub>OSCKD\_T2</sub> are reported as T<sub>OSDCK\_T</sub>/T<sub>OSCKD\_T</sub> in TRACE report.

## CLB Switching Characteristics

Table 24: CLB Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Combinatorial Delays</b>						
T <sub>ILO</sub>	An – Dn LUT address to A	0.10	0.11	0.13	0.15	ns, Max
T <sub>ILO_2</sub>	An – Dn LUT address to AMUX/CMUX	0.27	0.30	0.36	0.41	ns, Max
T <sub>ILO_3</sub>	An – Dn LUT address to BMUX_A	0.42	0.46	0.55	0.65	ns, Max
T <sub>I TO</sub>	An – Dn inputs to A – D Q outputs	0.94	1.05	1.27	1.51	ns, Max
T <sub>AXA</sub>	AX inputs to AMUX output	0.62	0.69	0.84	1.01	ns, Max
T <sub>AXB</sub>	AX inputs to BMUX output	0.58	0.66	0.83	0.98	ns, Max
T <sub>AXC</sub>	AX inputs to CMUX output	0.60	0.68	0.82	0.98	ns, Max
T <sub>AXD</sub>	AX inputs to DMUX output	0.68	0.75	0.90	1.08	ns, Max
T <sub>BXB</sub>	BX inputs to BMUX output	0.51	0.57	0.69	0.82	ns, Max
T <sub>BXD</sub>	BX inputs to DMUX output	0.62	0.69	0.82	0.99	ns, Max
T <sub>CXC</sub>	CX inputs to CMUX output	0.42	0.48	0.58	0.69	ns, Max
T <sub>CXD</sub>	CX inputs to DMUX output	0.53	0.59	0.71	0.86	ns, Max
T <sub>DXD</sub>	DX inputs to DMUX output	0.52	0.58	0.70	0.84	ns, Max
<b>Sequential Delays</b>						
T <sub>CKO</sub>	Clock to AQ – DQ outputs	0.40	0.44	0.53	0.62	ns, Max
T <sub>SHCKO</sub>	Clock to AMUX – DMUX outputs	0.47	0.53	0.66	0.73	ns, Max
<b>Setup and Hold Times of CLB Flip-Flops Before/After Clock CLK</b>						
T <sub>AS/T<sub>AH</sub></sub>	A <sub>N</sub> – D <sub>N</sub> input to CLK on A – D flip-flops	0.07/0.12	0.09/0.14	0.11/0.18	0.11/0.20	ns, Min
T <sub>DICK/T<sub>CKDI</sub></sub>	A <sub>X</sub> – D <sub>X</sub> input to CLK on A – D flip-flops	0.06/0.19	0.07/0.21	0.09/0.26	0.09/0.31	ns, Min
	A <sub>X</sub> – D <sub>X</sub> input through MUXs and/or carry logic to CLK on A – D flip-flops	0.59/0.08	0.66/0.09	0.81/0.11	0.97/0.12	ns, Min
T <sub>CECK_CLB/</sub> T <sub>CKCE_CLB</sub>	CE input to CLK on A – D flip-flops	0.15/0.00	0.17/0.00	0.21/0.01	0.34/–0.01	ns, Min
T <sub>SRCK/T<sub>CKSR</sub></sub>	SR input to CLK on A – D flip-flops	0.38/0.03	0.43/0.04	0.53/0.05	0.62/0.05	ns, Min
<b>Set/Reset</b>						
T <sub>SRMIN</sub>	SR input minimum pulse width	0.52	0.78	1.04	0.95	ns, Min
T <sub>RQ</sub>	Delay from SR input to AQ – DQ flip-flops	0.53	0.59	0.71	0.83	ns, Max
T <sub>CEO</sub>	Delay from CE input to AQ – DQ flip-flops	0.52	0.58	0.70	0.83	ns, Max
F <sub>TOG</sub>	Toggle frequency (for export control)	1412	1286	1098	1098	MHz

## CLB Distributed RAM Switching Characteristics (SLICEM Only)

Table 25: CLB Distributed RAM Switching Characteristics

Symbol	Description	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
<b>Sequential Delays</b>							
T <sub>SHCKO</sub>	Clock to A – B outputs	0.98	1.09	1.32	1.54	ns, Max	
T <sub>SHCKO_1</sub>	Clock to AMUX – BMUX outputs	1.37	1.53	1.86	2.18	ns, Max	
<b>Setup and Hold Times Before/After Clock CLK</b>							
T <sub>DS_LRAM</sub> /T <sub>DH_LRAM</sub>	A – D inputs to CLK	0.54/0.28	0.60/0.30	0.72/0.35	0.96/0.40	ns, Min	
T <sub>AS_LRAM</sub> /T <sub>AH_LRAM</sub>	Address An inputs to clock	0.27/0.55	0.30/0.60	0.37/0.70	0.43/0.71	ns, Min	
	Address An inputs through MUXs and/or carry logic to clock	0.69/0.18	0.77/0.21	0.94/0.26	1.11/0.29	ns, Min	
T <sub>WS_LRAM</sub> /T <sub>WH_LRAM</sub>	WE input to clock	0.38/0.10	0.43/0.12	0.53/0.17	0.62/0.13	ns, Min	
T <sub>CECK_LRAM</sub> / T <sub>CKCE_LRAM</sub>	CE input to CLK	0.39/0.10	0.44/0.11	0.53/0.17	0.63/0.12	ns, Min	
<b>Clock CLK</b>							
T <sub>MPW_LRAM</sub>	Minimum pulse width	1.05	1.13	1.25	0.82	ns, Min	
T <sub>MCP</sub>	Minimum clock period	2.10	2.26	2.50	1.64	ns, Min	

**Notes:**

1. A Zero "0" Hold Time listing indicates no hold time or a negative hold time.
2. T<sub>SHCKO</sub> also represents the CLK to XMUX output. Refer to TRACE report for the CLK to XMUX path.

## CLB Shift Register Switching Characteristics (SLICEM Only)

Table 26: CLB Shift Register Switching Characteristics

Symbol	Description	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
<b>Sequential Delays</b>							
T <sub>REG</sub>	Clock to A – D outputs	1.19	1.33	1.61	1.89	ns, Max	
T <sub>REG_MUX</sub>	Clock to AMUX – DMUX output	1.58	1.77	2.15	2.53	ns, Max	
T <sub>REG_M31</sub>	Clock to DMUX output via M31 output	1.12	1.23	1.46	1.68	ns, Max	
<b>Setup and Hold Times Before/After Clock CLK</b>							
T <sub>WS_SHFREG</sub> / T <sub>WH_SHFREG</sub>	WE input	0.37/0.10	0.41/0.12	0.51/0.17	0.59/0.13	ns, Min	
T <sub>CECK_SHFREG</sub> / T <sub>CKCE_SHFREG</sub>	CE input to CLK	0.37/0.10	0.42/0.11	0.52/0.17	0.60/0.12	ns, Min	
T <sub>DS_SHFREG</sub> / T <sub>DH_SHFREG</sub>	A – D inputs to CLK	0.33/0.34	0.37/0.37	0.44/0.43	0.54/0.47	ns, Min	
<b>Clock CLK</b>							
T <sub>MPW_SHFREG</sub>	Minimum pulse width	0.77	0.86	0.98	1.04	ns, Min	

**Notes:**

1. A Zero "0" Hold Time listing indicates no hold time or a negative hold time.

## Block RAM and FIFO Switching Characteristics

Table 27: Block RAM and FIFO Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Block RAM and FIFO Clock-to-Out Delays</b>						
T <sub>RCKO_DO</sub> and T <sub>RCKO_DO_REG</sub> <sup>(1)</sup>	Clock CLK to DOUT output (without output register) <sup>(2)(3)</sup>	1.85	2.13	2.46	2.87	ns, Max
	Clock CLK to DOUT output (with output register) <sup>(4)(5)</sup>	0.64	0.74	0.89	1.02	ns, Max
T <sub>RCKO_DO_ECC</sub> and T <sub>RCKO_DO_ECC_REG</sub>	Clock CLK to DOUT output with ECC (without output register) <sup>(2)(3)</sup>	2.77	3.04	3.84	5.30	ns, Max
	Clock CLK to DOUT output with ECC (with output register) <sup>(4)(5)</sup>	0.73	0.81	0.94	1.11	ns, Max
T <sub>RCKO_DO_CASCOUP</sub> and T <sub>RCKO_DO_CASCOUP_REG</sub>	Clock CLK to DOUT output with cascade (without output register) <sup>(2)</sup>	2.61	2.88	3.30	3.76	ns, Max
	Clock CLK to DOUT output with cascade (with output register) <sup>(4)</sup>	1.16	1.28	1.46	1.56	ns, Max
T <sub>RCKO_FLAGS</sub>	Clock CLK to FIFO flags outputs <sup>(6)</sup>	0.76	0.87	1.05	1.14	ns, Max
T <sub>RCKO_POINTERS</sub>	Clock CLK to FIFO pointers outputs <sup>(7)</sup>	0.94	1.02	1.15	1.30	ns, Max
T <sub>RCKO_PARITY_ECC</sub>	Clock CLK to ECCPARITY in ECC encode only mode	0.78	0.85	0.94	1.10	ns, Max
T <sub>RCKO_SDBIT_ECC</sub> and T <sub>RCKO_SDBIT_ECC_REG</sub>	Clock CLK to BITERR (without output register)	2.56	2.81	3.55	4.90	ns, Max
	Clock CLK to BITERR (with output register)	0.68	0.76	0.89	1.05	ns, Max
T <sub>RCKO_RDADDR_ECC</sub> and T <sub>RCKO_RDADDR_ECC_REG</sub>	Clock CLK to RDADDR output with ECC (without output register)	0.75	0.88	1.07	1.15	ns, Max
	Clock CLK to RDADDR output with ECC (with output register)	0.84	0.93	1.08	1.29	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>RCKC_ADDRA</sub> /T <sub>RCKC_ADDRA</sub>	ADDR inputs <sup>(8)</sup>	0.45/0.31	0.49/0.33	0.57/0.36	0.77/0.45	ns, Min
T <sub>RDCK_DI_WF_NC</sub> /T <sub>RCKD_DI_WF_NC</sub>	Data input setup/hold time when block RAM is configured in WRITE_FIRST or NO_CHANGE mode <sup>(9)</sup>	0.58/0.60	0.65/0.63	0.74/0.67	0.92/0.76	ns, Min
T <sub>RDCK_DI_RF</sub> /T <sub>RCKD_DI_RF</sub>	Data input setup/hold time when block RAM is configured in READ_FIRST mode <sup>(9)</sup>	0.20/0.29	0.22/0.34	0.25/0.41	0.29/0.38	ns, Min
T <sub>RDCK_DI_ECC</sub> /T <sub>RCKD_DI_ECC</sub>	DIN inputs with block RAM ECC in standard mode <sup>(9)</sup>	0.50/0.43	0.55/0.46	0.63/0.50	0.78/0.54	ns, Min
T <sub>RDCK_DI_ECCW</sub> /T <sub>RCKD_DI_ECCW</sub>	DIN inputs with block RAM ECC encode only <sup>(9)</sup>	0.93/0.43	1.02/0.46	1.17/0.50	1.38/0.48	ns, Min
T <sub>RDCK_DI_ECC_FIFO</sub> /T <sub>RCKD_DI_ECC_FIFO</sub>	DIN inputs with FIFO ECC in standard mode <sup>(9)</sup>	1.04/0.56	1.15/0.59	1.32/0.64	1.55/0.77	ns, Min
T <sub>RCKC_INJECTBITERR</sub> /T <sub>RCKC_INJECTBITERR</sub>	Inject single/double bit error in ECC mode	0.58/0.35	0.64/0.37	0.74/0.40	0.92/0.48	ns, Min
T <sub>RCKC_EN</sub> /T <sub>RCKC_EN</sub>	Block RAM enable (EN) input	0.35/0.20	0.39/0.21	0.45/0.23	0.57/0.26	ns, Min
T <sub>RCKC_REGCE</sub> /T <sub>RCKC_REGCE</sub>	CE input of output register	0.24/0.15	0.29/0.15	0.36/0.16	0.40/0.19	ns, Min
T <sub>RCKC_RSTREG</sub> /T <sub>RCKC_RSTREG</sub>	Synchronous RSTREG input	0.29/0.07	0.32/0.07	0.35/0.07	0.41/0.07	ns, Min

Table 28: DSP48E1 Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Clock to Outs from Pipeline Register Clock to Output Pins</b>						
T <sub>DSPCKO_P_MREG</sub>	CLK MREG to P output	1.68	1.93	2.31	2.73	ns
T <sub>DSPCKO_CARRYCASCOU_MREG</sub>	CLK MREG to CARRYCASCOU output	1.92	2.21	2.64	3.12	ns
T <sub>DSPCKO_P_ADREG_MULT</sub>	CLK ADREG to P output using multiplier	2.72	3.10	3.69	4.60	ns
T <sub>DSPCKO_CARRYCASCOU_ADREG_MULT</sub>	CLK ADREG to CARRYCASCOU output using multiplier	2.96	3.38	4.02	4.99	ns
<b>Clock to Outs from Input Register Clock to Output Pins</b>						
T <sub>DSPCKO_P_AREG_MULT</sub>	CLK AREG to P output using multiplier	3.94	4.51	5.37	6.84	ns
T <sub>DSPCKO_P_BREG</sub>	CLK BREG to P output not using multiplier	1.64	1.87	2.22	2.65	ns
T <sub>DSPCKO_P_CREG</sub>	CLK CREG to P output not using multiplier	1.69	1.93	2.30	2.81	ns
T <sub>DSPCKO_P_DREG_MULT</sub>	CLK DREG to P output using multiplier	3.91	4.48	5.32	6.77	ns
<b>Clock to Outs from Input Register Clock to Cascading Output Pins</b>						
T <sub>DSPCKO_{ACOUT; BCOUT}_{AREG; BREG}</sub>	CLK (ACOUT, BCOUT) to {A,B} register output	0.64	0.73	0.87	1.02	ns
T <sub>DSPCKO_CARRYCASCOU_{AREG, BREG}_MULT</sub>	CLK (AREG, BREG) to CARRYCASCOU output using multiplier	4.19	4.79	5.70	7.24	ns
T <sub>DSPCKO_CARRYCASCOU_BREG</sub>	CLK BREG to CARRYCASCOU output not using multiplier	1.88	2.15	2.55	3.04	ns
T <sub>DSPCKO_CARRYCASCOU_DREG_MULT</sub>	CLK DREG to CARRYCASCOU output using multiplier	4.16	4.76	5.65	7.17	ns
T <sub>DSPCKO_CARRYCASCOU_CREG</sub>	CLK CREG to CARRYCASCOU output	1.94	2.21	2.63	3.20	ns
<b>Maximum Frequency</b>						
F <sub>MAX</sub>	With all registers used	628.93	550.66	464.25	363.77	MHz
F <sub>MAX_PATDET</sub>	With pattern detector	531.63	465.77	392.93	310.08	MHz
F <sub>MAX_MULT_NOMREG</sub>	Two register multiply without MREG	349.28	305.62	257.47	210.44	MHz
F <sub>MAX_MULT_NOMREG_PATDET</sub>	Two register multiply without MREG with pattern detect	317.26	277.62	233.92	191.28	MHz
F <sub>MAX_PREADD_MULT_NOADREG</sub>	Without ADREG	397.30	346.26	290.44	223.26	MHz
F <sub>MAX_PREADD_MULT_NOADREG_PATDET</sub>	Without ADREG with pattern detect	397.30	346.26	290.44	223.26	MHz
F <sub>MAX_NOPIPELINEREG</sub>	Without pipeline registers (MREG, ADREG)	260.01	227.01	190.69	150.13	MHz
F <sub>MAX_NOPIPELINEREG_PATDET</sub>	Without pipeline registers (MREG, ADREG) with pattern detect	241.72	211.15	177.43	140.10	MHz

**Table 32: Horizontal Clock Buffer Switching Characteristics (BUFH)**

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BHCKO_O	BUFH delay from I to O	0.10	0.11	0.13	0.16	ns
T_BHCKC_CE/T_BHCKC_CE	CE pin setup and hold	0.19/0.13	0.22/0.15	0.28/0.21	0.35/0.08	ns
<b>Maximum Frequency</b>						
F_MAX_BUHF	Horizontal clock buffer (BUFH)	628.00	628.00	464.00	394.00	MHz

**Table 33: Duty Cycle Distortion and Clock-Tree Skew**

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
T_DCD_CLK	Global clock tree duty-cycle distortion <sup>(1)</sup>	All	0.20	0.20	0.20	0.25	ns
T_CKSKEW	Global clock tree skew <sup>(2)</sup>	XC7A100T	0.27	0.33	0.36	0.48	ns
		XC7A200T	0.40	0.48	0.54	0.69	ns
T_DCD_BUFIO	I/O clock tree duty cycle distortion	All	0.14	0.14	0.14	0.14	ns
T_BUFIOSKEW	I/O clock tree skew across one clock region	All	0.03	0.03	0.03	0.03	ns
T_DCD_BUFR	Regional clock tree duty cycle distortion	All	0.18	0.18	0.18	0.18	ns

**Notes:**

- These parameters represent the worst-case duty cycle distortion observable at the I/O flip flops. For all I/O standards, IBIS can be used to calculate any additional duty cycle distortion that might be caused by asymmetrical rise/fall times.
- The T\_CKSKEW value represents the worst-case clock-tree skew observable between sequential I/O elements. Significantly less clock-tree skew exists for I/O registers that are close to each other and fed by the same or adjacent clock-tree branches. Use the Xilinx FPGA\_Editor and Timing Analyzer tools to evaluate clock skew specific to your application.

## MMCM Switching Characteristics

**Table 34: MMCM Specification**

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
MMCM_F_INMAX	Maximum input clock frequency	800.00	800.00	800.00	800.00	MHz
MMCM_F_INMIN	Minimum input clock frequency	10.00	10.00	10.00	10.00	MHz
MMCM_F_INJITTER	Maximum input clock period jitter	< 20% of clock input period or 1 ns Max				
MMCM_F_INDUTY	Allowable input duty cycle: 10—49 MHz	25	25	25	25	%
	Allowable input duty cycle: 50—199 MHz	30	30	30	30	%
	Allowable input duty cycle: 200—399 MHz	35	35	35	35	%
	Allowable input duty cycle: 400—499 MHz	40	40	40	40	%
	Allowable input duty cycle: >500 MHz	45	45	45	45	%
MMCM_F_MIN_PSCLK	Minimum dynamic phase-shift clock frequency	0.01	0.01	0.01	0.01	MHz
MMCM_F_MAX_PSCLK	Maximum dynamic phase-shift clock frequency	550.00	500.00	450.00	450.00	MHz
MMCM_F_VCOMIN	Minimum MMCM VCO frequency	600.00	600.00	600.00	600.00	MHz
MMCM_F_VCOMAX	Maximum MMCM VCO frequency	1600.00	1440.00	1200.00	1200.00	MHz

Table 34: MMCM Specification (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
MMCM_F_BANDWIDTH	Low MMCM bandwidth at typical <sup>(1)</sup>	1.00	1.00	1.00	1.00	MHz
	High MMCM bandwidth at typical <sup>(1)</sup>	4.00	4.00	4.00	4.00	MHz
MMCM_T_STATPHAOFFSET	Static phase offset of the MMCM outputs <sup>(2)</sup>	0.12	0.12	0.12	0.12	ns
MMCM_T_OUTJITTER	MMCM output jitter	Note 3				
MMCM_T_OUTDUTY	MMCM output clock duty-cycle precision <sup>(4)</sup>	0.20	0.20	0.20	0.25	ns
MMCM_T_LOCKMAX	MMCM maximum lock time	100.00	100.00	100.00	100.00	μs
MMCM_F_OUTMAX	MMCM maximum output frequency	800.00	800.00	800.00	800.00	MHz
MMCM_F_OUTMIN	MMCM minimum output frequency <sup>(5)(6)</sup>	4.69	4.69	4.69	4.69	MHz
MMCM_T_EXTFDVAR	External clock feedback variation	< 20% of clock input period or 1 ns Max				
MMCM_RST_MINPULSE	Minimum reset pulse width	5.00	5.00	5.00	5.00	ns
MMCM_F_PFDMAX	Maximum frequency at the phase frequency detector	550.00	500.00	450.00	450.00	MHz
MMCM_F_PFDMIN	Minimum frequency at the phase frequency detector	10.00	10.00	10.00	10.00	MHz
MMCM_T_FBDelay	Maximum delay in the feedback path	3 ns Max or one CLKIN cycle				
<b>MMCM Switching Characteristics Setup and Hold</b>						
T_MMCM_DCK_PSEN/ T_MMCM_CKD_PSEN	Setup and hold of phase-shift enable	1.04/0.00	1.04/0.00	1.04/0.00	1.04/0.00	ns
T_MMCM_DCK_PSINCDEC/ T_MMCM_CKD_PSINCDEC	Setup and hold of phase-shift increment/decrement	1.04/0.00	1.04/0.00	1.04/0.00	1.04/0.00	ns
T_MMCM_CKO_PSDONE	Phase shift clock-to-out of PSDONE	0.59	0.68	0.81	0.78	ns
<b>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</b>						
T_MMCM_DCK_DADDR/ T_MMCM_CKD_DADDR	DADDR setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T_MMCM_DCK_DI/ T_MMCM_CKD_DI	DI setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T_MMCM_DCK_DEN/ T_MMCM_CKD_DEN	DEN setup/hold	1.76/0.00	1.97/0.00	2.29/0.00	2.40/0.00	ns, Min
T_MMCM_DCK_DWE/ T_MMCM_CKD_DWE	DWE setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T_MMCM_CKO_DRDY	CLK to out of DRDY	0.65	0.72	0.99	0.70	ns, Max
F_DCK	DCLK frequency	200.00	200.00	200.00	100.00	MHz, Max

**Notes:**

- The MMCM does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
- The static offset is measured between any MMCM outputs with identical phase.
- Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
- Includes global clock buffer.
- Calculated as  $F_{VCO}/128$  assuming output duty cycle is 50%.
- When CLKOUT4\_CASCADE = TRUE, MMCM\_F\_OUTMIN is 0.036 MHz.

## PLL Switching Characteristics

Table 35: PLL Specification

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
PLL_F <sub>INMAX</sub>	Maximum input clock frequency	800.00	800.00	800.00	800.00	MHz
PLL_F <sub>INMIN</sub>	Minimum input clock frequency	19.00	19.00	19.00	19.00	MHz
PLL_F <sub>INJITTER</sub>	Maximum input clock period jitter	< 20% of clock input period or 1 ns Max				
PLL_F <sub>INDUTY</sub>	Allowable input duty cycle: 19—49 MHz	25	25	25	25	%
	Allowable input duty cycle: 50—199 MHz	30	30	30	30	%
	Allowable input duty cycle: 200—399 MHz	35	35	35	35	%
	Allowable input duty cycle: 400—499 MHz	40	40	40	40	%
	Allowable input duty cycle: >500 MHz	45	45	45	45	%
PLL_F <sub>VCOMIN</sub>	Minimum PLL VCO frequency	800.00	800.00	800.00	800.00	MHz
PLL_F <sub>VCOMAX</sub>	Maximum PLL VCO frequency	2133.00	1866.00	1600.00	1600.00	MHz
PLL_F <sub>BANDWIDTH</sub>	Low PLL bandwidth at typical <sup>(1)</sup>	1.00	1.00	1.00	1.00	MHz
	High PLL bandwidth at typical <sup>(1)</sup>	4.00	4.00	4.00	4.00	MHz
PLL_T <sub>STATPHAOFFSET</sub>	Static phase offset of the PLL outputs <sup>(2)</sup>	0.12	0.12	0.12	0.12	ns
PLL_T <sub>OUTJITTER</sub>	PLL output jitter	Note 3				
PLL_T <sub>OUTDUTY</sub>	PLL output clock duty-cycle precision <sup>(4)</sup>	0.20	0.20	0.20	0.25	ns
PLL_T <sub>LOCKMAX</sub>	PLL maximum lock time	100.00	100.00	100.00	100.00	μs
PLL_F <sub>OUTMAX</sub>	PLL maximum output frequency	800.00	800.00	800.00	800.00	MHz
PLL_F <sub>OUTMIN</sub>	PLL minimum output frequency <sup>(5)</sup>	6.25	6.25	6.25	6.25	MHz
PLL_T <sub>EXTFDVAR</sub>	External clock feedback variation	< 20% of clock input period or 1 ns Max				
PLL_RST <sub>MINPULSE</sub>	Minimum reset pulse width	5.00	5.00	5.00	5.00	ns
PLL_F <sub>PFDMAX</sub>	Maximum frequency at the phase frequency detector	550.00	500.00	450.00	450.00	MHz
PLL_F <sub>PFDMIN</sub>	Minimum frequency at the phase frequency detector	19.00	19.00	19.00	19.00	MHz
PLL_T <sub>FBDELAY</sub>	Maximum delay in the feedback path	3 ns Max or one CLKIN cycle				

### Dynamic Reconfiguration Port (DRP) for PLL Before and After DCLK

T <sub>PLLDCK_DADDR</sub> /T <sub>PLLCKD_DADDR</sub>	Setup and hold of D address	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLDCK_DI</sub> /T <sub>PLLCKD_DI</sub>	Setup and hold of D input	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLDCK_DEN</sub> /T <sub>PLLCKD_DEN</sub>	Setup and hold of D enable	1.76/0.00	1.97/0.00	2.29/0.00	2.40/0.00	ns, Min
T <sub>PLLDCK_DWE</sub> /T <sub>PLLCKD_DWE</sub>	Setup and hold of D write enable	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLCKO_DRDY</sub>	CLK to out of DRDY	0.65	0.72	0.99	0.99	ns, Max
F <sub>DCK</sub>	DCLK frequency	200.00	200.00	200.00	100.00	MHz, Max

#### Notes:

1. The PLL does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
2. The static offset is measured between any PLL outputs with identical phase.
3. Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
4. Includes global clock buffer.
5. Calculated as F<sub>VCO</sub>/128 assuming output duty cycle is 50%.

## Device Pin-to-Pin Input Parameter Guidelines

All devices are 100% functionally tested. Values are expressed in nanoseconds unless otherwise noted.

**Table 41: Global Clock Input Setup and Hold Without MMCM/PLL with ZHOLD\_DELAY on HR I/O Banks**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
T <sub>PSFD</sub> / T <sub>PHFD</sub>	Full delay (legacy delay or default delay) global clock input and IFF <sup>(2)</sup> without MMCM/PLL with ZHOLD_DELAY on HR I/O banks	XC7A100T	2.69/-0.46	2.89/-0.46	3.34/-0.46	5.66/-0.52	ns	
		XC7A200T	3.03/-0.50	3.27/-0.50	3.79/-0.50	6.66/-0.53	ns	

**Notes:**

1. Setup and hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the global clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the global clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input flip-flop or latch
3. A zero "0" hold time listing indicates no hold time or a negative hold time.

**Table 42: Clock-Capable Clock Input Setup and Hold With MMCM**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
T <sub>PSMMCMCC</sub> / T <sub>PHMMCMCC</sub>	No delay clock-capable clock input and IFF <sup>(2)</sup> with MMCM	XC7A100T	2.44/-0.62	2.80/-0.62	3.36/-0.62	2.15/-0.49	ns	
		XC7A200T	2.57/-0.63	2.94/-0.63	3.52/-0.63	2.32/-0.53	ns	

**Notes:**

1. Setup and hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the global clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the global clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input flip-flop or latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

**Table 43: Clock-Capable Clock Input Setup and Hold With PLL**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Clock-Capable Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
T <sub>PSPLLCC</sub> / T <sub>PHPLLCC</sub>	No delay clock-capable clock input and IFF <sup>(2)</sup> with PLL	XC7A100T	2.78/-0.32	3.15/-0.32	3.78/-0.32	2.47/-0.60	ns	
		XC7A200T	2.91/-0.33	3.29/-0.33	3.94/-0.33	2.64/-0.63	ns	

**Notes:**

1. Setup and hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the global clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the global clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input flip-flop or latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

**Table 44: Data Input Setup and Hold Times Relative to a Forwarded Clock Input Pin Using BUFIO**

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to a Forwarded Clock Input Pin Using BUFIO for SSTL15 Standard.						
T <sub>PSCS</sub> /T <sub>PHCS</sub>	Setup and hold of I/O clock	-0.38/1.31	-0.38/1.46	-0.38/1.76	-0.16/1.89	ns

**Table 45: Sample Window**

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T <sub>SAMP</sub>	Sampling error at receiver pins <sup>(1)</sup>	0.59	0.64	0.70	0.70	ns
T <sub>SAMP_BUFI0</sub>	Sampling error at receiver pins using BUFIO <sup>(2)</sup>	0.35	0.40	0.46	0.46	ns

**Notes:**

1. This parameter indicates the total sampling error of the Artix-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the MMCM to capture the DDR input registers' edges of operation. These measurements include:
  - CLKO MMCM jitter
  - MMCM accuracy (phase offset)
  - MMCM phase shift resolution
 These measurements do not include package or clock tree skew.
2. This parameter indicates the total sampling error of the Artix-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the BUFIO clock network and IDELAY to capture the DDR input registers' edges of operation. These measurements do not include package or clock tree skew.

**Additional Package Parameter Guidelines**

The parameters in this section provide the necessary values for calculating timing budgets for Artix-7 FPGA clock transmitter and receiver data-valid windows.

**Table 46: Package Skew**

Symbol	Description	Device	Package	Value	Units
T <sub>PKGSKEW</sub>	Package skew <sup>(1)</sup>	XC7A100T	CSG324	113	ps
			FTG256	120	ps
			FGG484	144	ps
			FGG676	153	ps
		XC7A200T	SBG484	111	ps
			FBG484	109	ps
			FBG676	121	ps
			FFG1156	151	ps

**Notes:**

1. These values represent the worst-case skew between any two SelectIO resources in the package: shortest delay to longest delay from die pad to ball.
2. Package delay information is available for these device/package combinations. This information can be used to deskew the package.

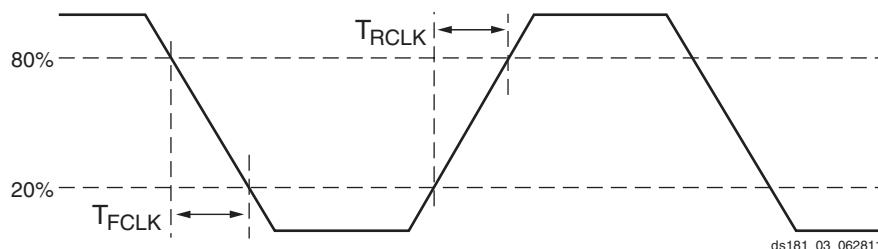


Figure 3: Reference Clock Timing Parameters

Table 52: GTP Transceiver PLL/Lock Time Adaptation

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
T <sub>LOCK</sub>	Initial PLL lock		—	—	1	ms
T <sub>DLOCK</sub>	Clock recovery phase acquisition and adaptation time.	After the PLL is locked to the reference clock, this is the time it takes to lock the clock data recovery (CDR) to the data present at the input.	—	50,000	2.3 x 10 <sup>6</sup>	UI

Table 53: GTP Transceiver User Clock Switching Characteristics<sup>(1)</sup>

Symbol	Description	Conditions	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
F <sub>TXOUT</sub>	TXOUTCLK maximum frequency		412.500	412.500	234.375	234.375	MHz
F <sub>RXOUT</sub>	RXOUTCLK maximum frequency		412.500	412.500	234.375	234.375	MHz
F <sub>TXIN</sub>	TXUSRCLK maximum frequency	16-bit data path	412.500	412.500	234.375	234.375	MHz
F <sub>RXIN</sub>	RXUSRCLK maximum frequency	16-bit data path	412.500	412.500	234.375	234.375	MHz
F <sub>TXIN2</sub>	TXUSRCLK2 maximum frequency	16-bit data path	412.500	412.500	234.375	234.375	MHz
F <sub>RXIN2</sub>	RXUSRCLK2 maximum frequency	16-bit data path	412.500	412.500	234.375	234.375	MHz

**Notes:**

1. Clocking must be implemented as described in [UG482: 7 Series FPGAs GTP Transceiver User Guide](#).

## GTP Transceiver Protocol Jitter Characteristics

For Table 56 through Table 60, the [UG482: 7 Series FPGAs GTP Transceiver User Guide](#) contains recommended settings for optimal usage of protocol specific characteristics.

**Table 56: Gigabit Ethernet Protocol Characteristics**

Description	Line Rate (Mb/s)	Min	Max	Units
<b>Gigabit Ethernet Transmitter Jitter Generation</b>				
Total transmitter jitter (T_TJ)	1250	–	0.24	UI
<b>Gigabit Ethernet Receiver High Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	1250	0.749	–	UI

**Table 57: XAUI Protocol Characteristics**

Description	Line Rate (Mb/s)	Min	Max	Units
<b>XAUI Transmitter Jitter Generation</b>				
Total transmitter jitter (T_TJ)	3125	–	0.35	UI
<b>XAUI Receiver High Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	3125	0.65	–	UI

**Table 58: PCI Express Protocol Characteristics<sup>(1)</sup>**

Standard	Description	Line Rate (Mb/s)	Min	Max	Units
<b>PCI Express Transmitter Jitter Generation</b>					
PCI Express Gen 1	Total transmitter jitter	2500	–	0.25	UI
PCI Express Gen 2	Total transmitter jitter	5000	–	0.25	UI
<b>PCI Express Receiver High Frequency Jitter Tolerance</b>					
PCI Express Gen 1	Total receiver jitter tolerance	2500	0.65	–	UI
PCI Express Gen 2 <sup>(2)</sup>	Receiver inherent timing error	5000	0.40	–	UI
	Receiver inherent deterministic timing error		0.30	–	UI

**Notes:**

1. Tested per card electromechanical (CEM) methodology.
2. Using common REFCLK.

**Table 59: CEI-6G Protocol Characteristics**

Description	Line Rate (Mb/s)	Interface	Min	Max	Units
<b>CEI-6G Transmitter Jitter Generation</b>					
Total transmitter jitter <sup>(1)</sup>	4976–6375	CEI-6G-SR	–	0.3	UI
<b>CEI-6G Receiver High Frequency Jitter Tolerance</b>					
Total receiver jitter tolerance <sup>(1)</sup>	4976–6375	CEI-6G-SR	0.6	–	UI

**Notes:**

1. Tested at most commonly used line rate of 6250 Mb/s using 390.625 MHz reference clock.

**Table 60: CPRI Protocol Characteristics**

Description	Line Rate (Mb/s)	Min	Max	Units
<b>CPRI Transmitter Jitter Generation</b>				
Total transmitter jitter	614.4	–	0.35	UI
	1228.8	–	0.35	UI
	2457.6	–	0.35	UI
	3072.0	–	0.35	UI
	4915.2	–	0.3	UI
	6144.0	–	0.3	UI
<b>CPRI Receiver Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	614.4	0.65	–	UI
	1228.8	0.65	–	UI
	2457.6	0.65	–	UI
	3072.0	0.65	–	UI
	4915.2 <sup>(1)</sup>	0.60	–	UI
	6144.0 <sup>(1)</sup>	0.60	–	UI

**Notes:**

1. Tested to CEI-6G-SR.

**Integrated Interface Block for PCI Express Designs Switching Characteristics**

More information and documentation on solutions for PCI Express designs can be found at:

<http://www.xilinx.com/technology/protocols/pciexpress.htm>

**Table 61: Maximum Performance for PCI Express Designs**

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
FPIPECLK	Pipe clock maximum frequency	250.00	250.00	250.00	250.00	MHz
FUSERCLK	User clock maximum frequency	250.00	250.00	250.00	250.00	MHz
FUSERCLK2	User clock 2 maximum frequency	250.00	250.00	250.00	250.00	MHz
FRPCLK	DRP clock maximum frequency	250.00	250.00	250.00	250.00	MHz

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